Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/653,019	LUO ET AL.	
Examiner	Art Unit	
Yuzhen Ge	2624	

	SEAR	CHED					
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Class	Subclass	Date	Examiner				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, 'IBM_TDB, USOCR) - See search history printout	3/6/2007	YG